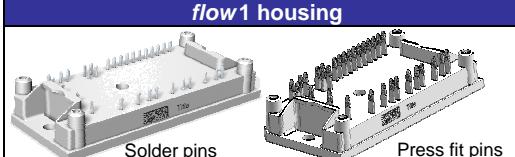
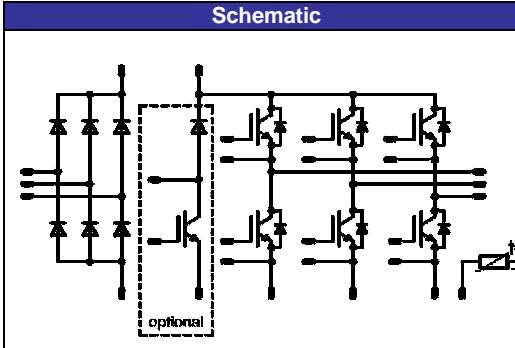


flowPIM 1		600V/50A
Features		
<ul style="list-style-type: none"> • 3~rectifier, optional BRC, Inverter, NTC • Very compact housing, easy to route • IGBT! / EmCon4 technology for low saturation losses and improved EMC behaviour 		
Target Applications		Schematic
<ul style="list-style-type: none"> • Industrial drives • Embedded drives 		
Types		
<ul style="list-style-type: none"> • V23990-P586-A20-PM • V23990-P586-A20Y-PM • V23990-P586-A208-PM • V23990-P586-C20-PM • V23990-P586-C20Y-PM 		

Maximum Ratings

$T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Input Rectifier Diode				
Repetitive peak reverse voltage	V_{RRM}		1600	V
DC forward current	I_{FAV}	$T_j=T_{j\max}$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	33 47	A
Surge forward current	I_{FSM}	$t_p=10\text{ms}$ $T_j=25^\circ\text{C}$	250	A
I^2t -value	I^2t	50 Hz half sine wave	310	A^2s
Power dissipation per Diode	P_{tot}	$T_j=T_{j\max}$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	37 60	W
Maximum Junction Temperature	$T_{j\max}$		150	$^\circ\text{C}$

Inverter Transistor

Collector-emitter break down voltage	V_{CE}		600	V
DC collector current	I_C	$T_j=T_{j\max}$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	38 48	A
Pulsed collector current	I_{Cpulse}	t_p limited by $T_{j\max}$	150	A
Turn off safe operating area		$V_{CE} \leq 1200\text{V}$, $T_j \leq T_{j\max}$	150	A
Power dissipation per IGBT	P_{tot}	$T_j=T_{j\max}$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	70 106	W
Gate-emitter peak voltage	V_{GE}		± 20	V
Short circuit ratings	t_{sc} V_{CC}	$T_j \leq 150^\circ\text{C}$ $V_{GE}=15\text{V}$	6 360	μs V
Maximum Junction Temperature	$T_{j\max}$		175	$^\circ\text{C}$

Maximum Ratings

$T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Inverter Diode				
Peak Repetitive Reverse Voltage	V_{RRM}		600	V
DC forward current	I_F	$T_j=T_j\max$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	36 48	A
Repetitive peak forward current	I_{FRM}	t_p limited by $T_j\max$	100	A
Power dissipation per Diode	P_{tot}	$T_j=T_j\max$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	58 87	W
Maximum Junction Temperature	$T_j\max$		175	°C
Brake Transistor				
Collector-emitter break down voltage	V_{CE}		600	V
DC collector current	I_C	$T_j=T_j\max$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	26 33	A
Pulsed collector current	I_{Cpuls}	t_p limited by $T_j\max$	90	A
Turn off safe operating area		$V_{CE} \leq 1200\text{V}$, $T_j \leq T_{op\max}$	90	A
Power dissipation per IGBT	P_{tot}	$T_j=T_j\max$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	46 70	W
Gate-emitter peak voltage	V_{GE}		±20	V
Short circuit ratings	t_{sc} V_{CC}	$T_j \leq 150^\circ\text{C}$ $V_{GE}=15\text{V}$	6 360	μs V
Maximum Junction Temperature	$T_j\max$		175	°C
Brake Diode				
Peak Repetitive Reverse Voltage	V_{RRM}		600	V
DC forward current	I_F	$T_j=T_j\max$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	13 18	A
Repetitive peak forward current	I_{FRM}	t_p limited by $T_j\max$	40	A
Power dissipation per Diode	P_{tot}	$T_j=T_j\max$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	20 30	W
Maximum Junction Temperature	$T_j\max$		175	°C
Thermal Properties				
Storage temperature	T_{stg}		-40...+125	°C
Operation temperature under switching condition	T_{op}		-40...+($T_j\max - 25$)	°C
Insulation Properties				
Insulation voltage	V_{is}	$t=2\text{s}$ DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm
Comparative tracking index	CTI		>200	

Characteristic Values

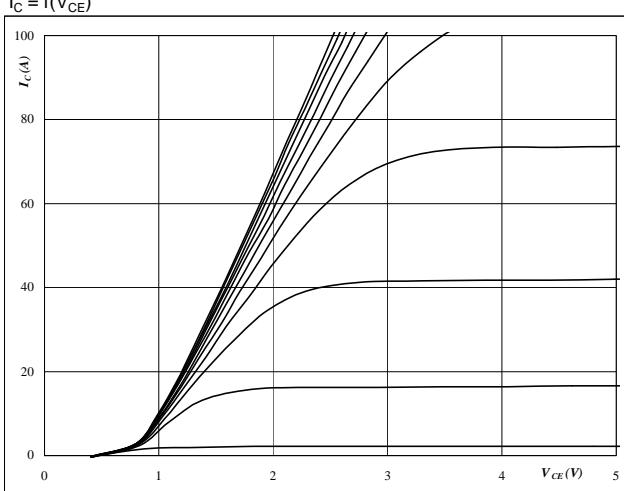
Parameter	Symbol	Conditions				Value			Unit	
		V_{GE} [V] or V_{GS} [V]	V_r [V] or V_{CE} [V] or V_{DS} [V]	I_c [A] or I_F [A] or I_D [A]	T_j	Min	Typ	Max		
Input Rectifier Diode										
Forward voltage	V_F			30	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	0,8	1,16 1,13	1,6	V	
Threshold voltage (for power loss calc. only)	V_{to}			30	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,90 0,78	0,83	V	
Slope resistance (for power loss calc. only)	r_t			30	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		8 11		$\text{m}\Omega$	
Reverse current	I_r		1500		$T_j=25^\circ\text{C}$ $T_j=150^\circ\text{C}$			2	mA	
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$					1,89		K/W	
Thermal resistance chip to heatsink per chip	R_{thJH}	Preapplied Phase change material					1,19		K/W	
Inverter Transistor										
Gate emitter threshold voltage	$V_{GE(\text{th})}$	$V_{CE}=V_{GE}$		0,0008	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	5	5,8	6,5	V	
Collector-emitter saturation voltage	$V_{CE(\text{sat})}$		15	50	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		1,76 2,06		V	
Collector-emitter cut-off current incl. Diode	I_{CES}		0	600	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			0,04 1	mA	
Gate-emitter leakage current	I_{GES}		20	0	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			600	nA	
Integrated Gate resistor	R_{gint}						-		Ω	
Turn-on delay time	$t_{d(on)}$	$R_{goff}=16 \Omega$ $R_{gon}=16 \Omega$	± 15	300	50	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	168 171		ns	
Rise time	t_r					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	23 27			
Turn-off delay time	$t_{d(off)}$					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	213 228			
Fall time	t_f					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	84 100			
Turn-on energy loss per pulse	E_{on}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	1,19 1,60		mWs	
Turn-off energy loss per pulse	E_{off}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	1,20 1,55			
Input capacitance	C_{ies}	$f=1\text{MHz}$	0	25		$T_j=25^\circ\text{C}$	3140		pF	
Output capacitance	C_{oss}						200			
Reverse transfer capacitance	C_{rss}						93			
Gate charge	Q_{Gate}		± 15			$T_j=25^\circ\text{C}$	310		nC	
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$					1,25		K/W	
Thermal resistance chip to heatsink per chip	R_{thJH}	Preapplied Phase change material					1,06		K/W	
Inverter Diode										
Diode forward voltage	V_F	$R_{gon}=16 \Omega$		50		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	1,2	1,85 1,94	1,9	V
Peak reverse recovery current	I_{RRM}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		37 42		A
Reverse recovery time	t_{rr}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		144 217		ns
Reverse recovered charge	Q_{rr}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		1,9 3,4		μC
Peak rate of fall of recovery current	$di(\text{rec})/\text{max dt}$					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		1568 1145		$\text{A}/\mu\text{s}$
Reverse recovered energy	E_{rec}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,31 0,60		mWs
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$					1,65		K/W	
Thermal resistance chip to heatsink per chip	R_{thJH}	Preapplied Phase change material					1,4		K/W	

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] or V_{GS} [V]	V_r [V] or V_{CE} [V] or V_{DS} [V]	I_c [A] or I_F [A] or I_D [A]	T_j	Min	Typ	Max	
Brake Transistor										
Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}$			0,00043	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	4,1	4,9	5,7	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		30	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	1,1	1,55 1,74	1,9	V
Collector-emitter cut-off incl diode	I_{CES}		0	600		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,04 1,00		mA
Gate-emitter leakage current	I_{GES}		20	0		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			300	nA
Integrated Gate resistor	R_{gint}							-		Ω
Turn-on delay time	$t_{d(on)}$	$R_{goff}=16 \Omega$ $R_{gon}=16 \Omega$	± 15	300	30	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		95 95		ns
Rise time	t_r					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		16 19		
Turn-off delay time	$t_{d(off)}$					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		141 157		
Fall time	t_f					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		86 99		
Turn-on energy loss per pulse	E_{on}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,50 0,72		mWs
Turn-off energy loss per pulse	E_{off}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,63 0,85		
Input capacitance	C_{ies}	$f=1\text{MHz}$	0	25		$T_j=25^\circ\text{C}$		1630		pF
Output capacitance	C_{oss}							108		
Reverse transfer capacitance	C_{rss}							50		
Gate charge	Q_{Gate}					$T_j=25^\circ\text{C}$		167		nC
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$						2,07		K/W
Thermal resistance chip to heatsink per chip	R_{thJH}	Preapplied Phase change material						1,78		K/W
Brake Diode										
Diode forward voltage	V_F				20	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	1,25 1,28	1,42 1,28	1,95	V
Reverse leakage current	I_r			600		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			27	μA
Peak reverse recovery current	I_{RRM}	$R_{gon}=16 \Omega$ $R_{goff}=16 \Omega$	15	300	20	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		19 20		A
Reverse recovery time	t_{rr}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		33 237		ns
Reverse recovered charge	Q_{rr}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,81 0,81		μC
Peak rate of fall of recovery current	$d(i_{rec})/\text{dt}$					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		1684 920		$\text{A}/\mu\text{s}$
Reverse recovery energy	E_{rec}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,14 0,30		mWs
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$						3,58		K/W
Thermal resistance chip to heatsink per chip	R_{thJH}	Preapplied Phase change material						3,11		K/W
Thermistor										
Rated resistance	R					$T_j=25^\circ\text{C}$		22000		Ω
Deviation of R ₂₅	$\Delta R/R$					$T=25^\circ\text{C}$	-5		5	%
Power dissipation	P					$T=25^\circ\text{C}$		200		mW
Power dissipation constant						$T_j=25^\circ\text{C}$		2		mW/K
B-value	$B_{(25/50)}$	Tol. ±3%				$T_j=25^\circ\text{C}$		3950		K
B-value	$B_{(25/100)}$					$T_j=25^\circ\text{C}$		3996		K
Vincotech NTC Reference						$T_j=25^\circ\text{C}$			B	

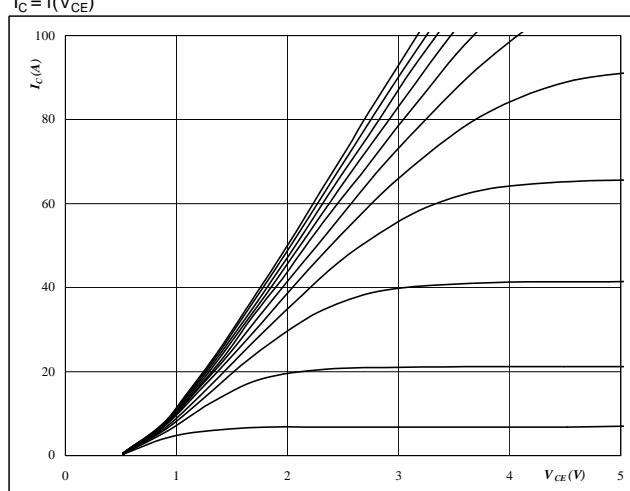
Output Inverter

Figure 1
Typical output characteristics
 $I_C = f(V_{CE})$



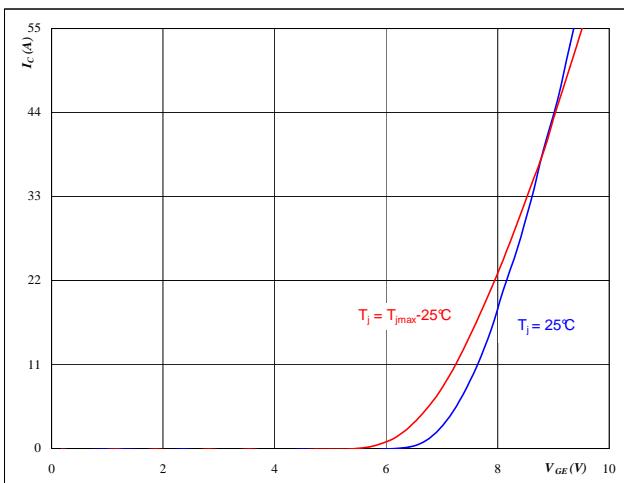
At
 $t_p = 250 \mu s$
 $T_j = 25^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 2
Typical output characteristics
 $I_C = f(V_{CE})$



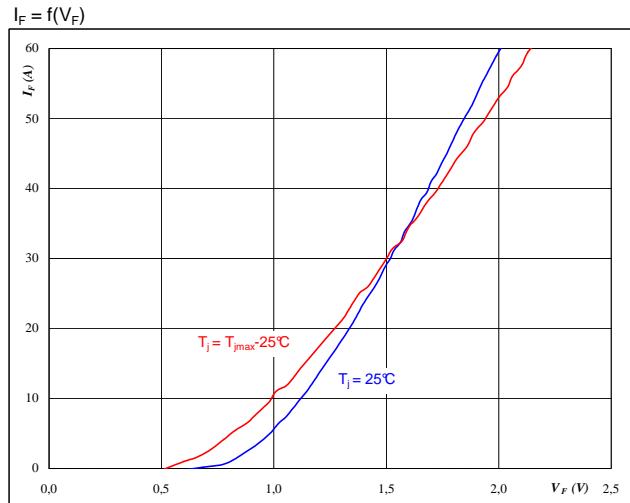
At
 $t_p = 250 \mu s$
 $T_j = 125^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 3
Typical transfer characteristics
 $I_C = f(V_{GE})$



At
 $t_p = 250 \mu s$
 $V_{CE} = 10 V$

Figure 4
Typical diode forward current as a function of forward voltage
 $I_F = f(V_F)$



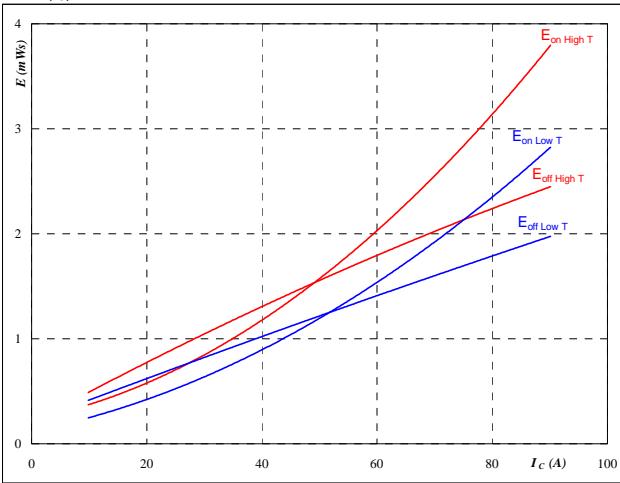
At
 $t_p = 250 \mu s$

Output Inverter

Figure 5

**Typical switching energy losses
as a function of collector current**

$$E = f(I_C)$$



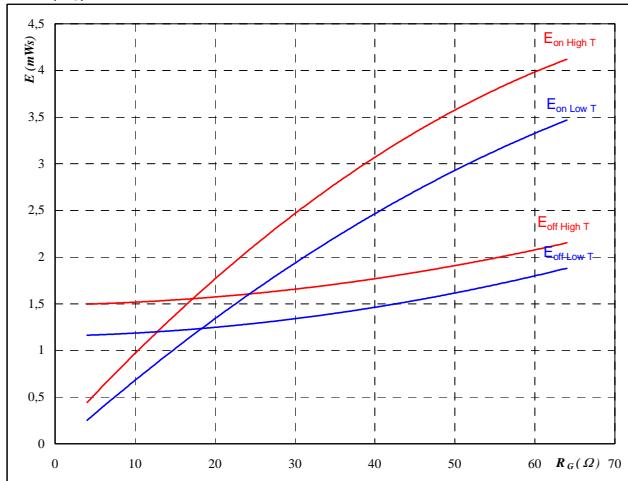
With an inductive load at

$$\begin{aligned} T_j &= \textcolor{red}{25/125} \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 16 \quad \Omega \\ R_{goff} &= 16 \quad \Omega \end{aligned}$$

Output inverter IGBT
Figure 6

**Typical switching energy losses
as a function of gate resistor**

$$E = f(R_G)$$



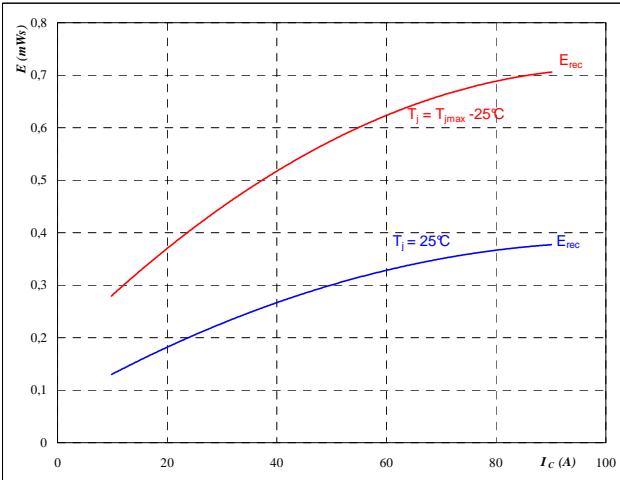
With an inductive load at

$$\begin{aligned} T_j &= \textcolor{red}{25/125} \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ I_C &= 50 \quad \text{A} \end{aligned}$$

Figure 7
Output inverter FWD

**Typical reverse recovery energy loss
as a function of collector current**

$$E_{rec} = f(I_C)$$



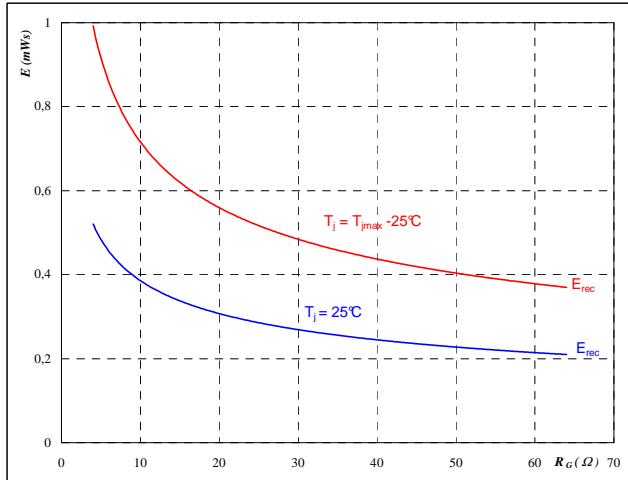
With an inductive load at

$$\begin{aligned} T_j &= \textcolor{red}{25/125} \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 16 \quad \Omega \end{aligned}$$

Figure 8
Output inverter FWD

**Typical reverse recovery energy loss
as a function of gate resistor**

$$E_{rec} = f(R_G)$$



With an inductive load at

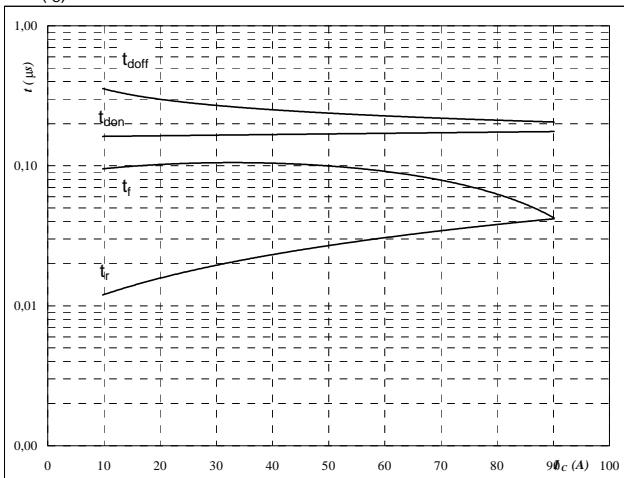
$$\begin{aligned} T_j &= \textcolor{red}{25/125} \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ I_C &= 50 \quad \text{A} \end{aligned}$$

Output Inverter

Figure 9

Typical switching times as a function of collector current

$$t = f(I_C)$$



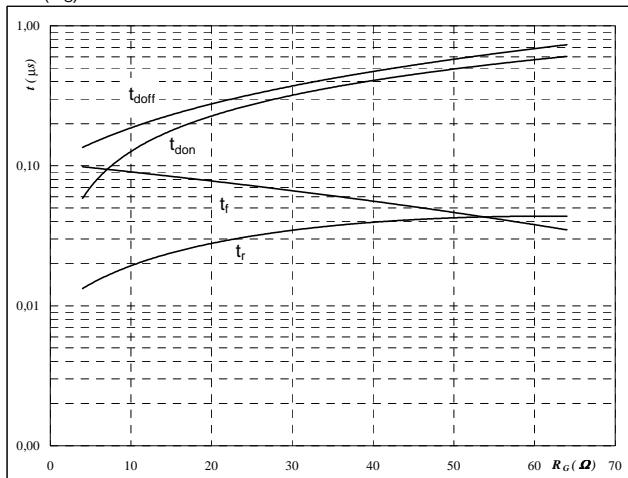
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	300	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω
$R_{goff} =$	16	Ω

Output inverter IGBT
Figure 10

Typical switching times as a function of gate resistor

$$t = f(R_G)$$



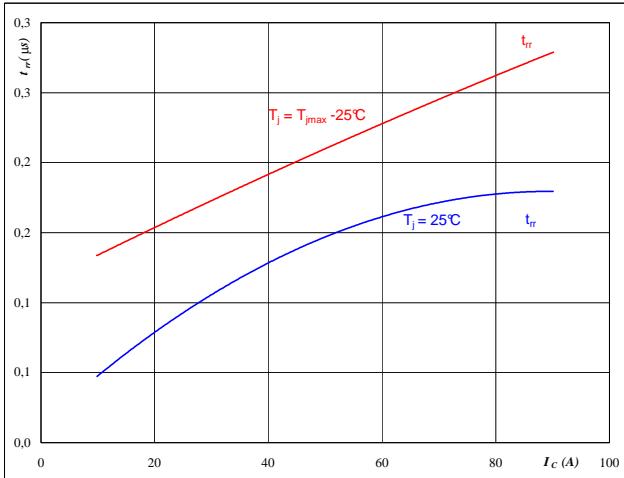
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	300	V
$V_{GE} =$	±15	V
$I_C =$	50	A

Figure 11
Output inverter FWD

Typical reverse recovery time as a function of collector current

$$t_{rr} = f(I_C)$$



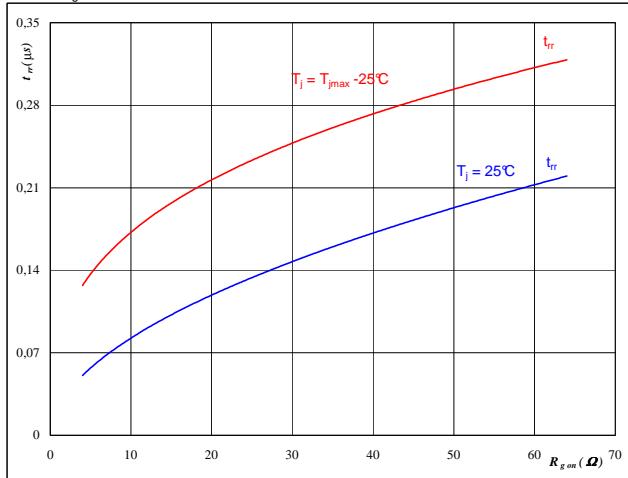
At

$T_j =$	25/125	°C
$V_{CE} =$	300	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω

Figure 12
Output inverter FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$$t_{rr} = f(R_{gon})$$



At

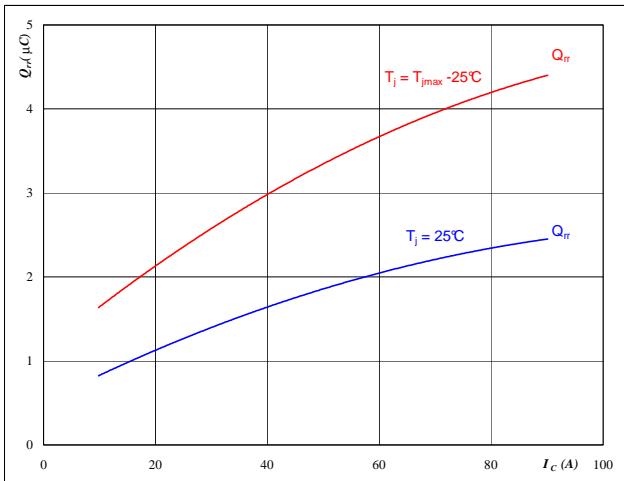
$T_j =$	25/125	°C
$V_R =$	300	V
$I_F =$	50	A
$V_{GE} =$	±15	V

Output Inverter

Figure 13

Typical reverse recovery charge as a function of collector current

$$Q_{rr} = f(I_C)$$

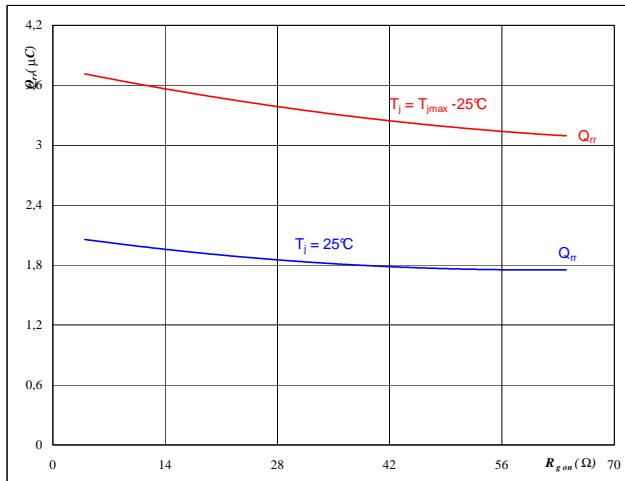

At

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 16 \quad \Omega \end{aligned}$$

Output inverter FWD
Figure 14

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$$Q_{rr} = f(R_{gon})$$

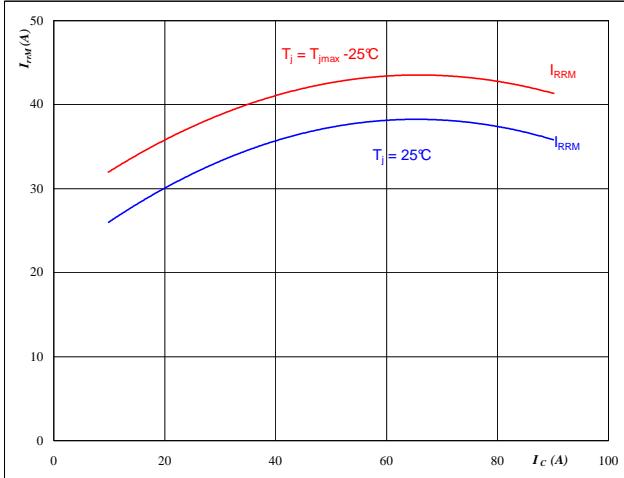

At

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_R &= 300 \quad \text{V} \\ I_F &= 50 \quad \text{A} \\ V_{GE} &= \pm 15 \quad \text{V} \end{aligned}$$

Figure 15
Output inverter FWD

Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(I_C)$$

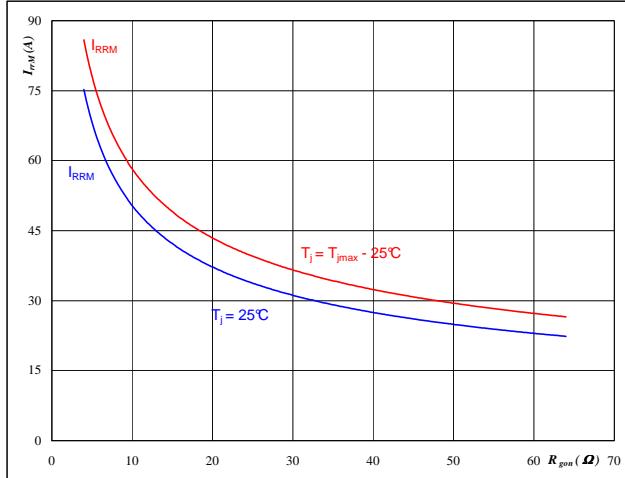

At

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 16 \quad \Omega \end{aligned}$$

Figure 16
Output inverter FWD

Typical reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RRM} = f(R_{gon})$$

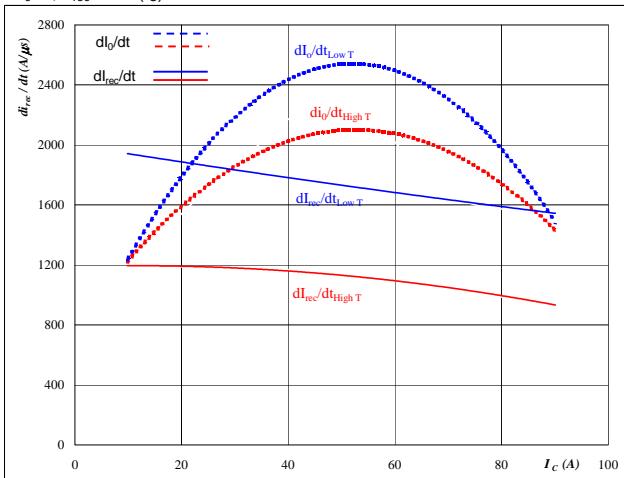

At

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_R &= 300 \quad \text{V} \\ I_F &= 50 \quad \text{A} \\ V_{GE} &= \pm 15 \quad \text{V} \end{aligned}$$

Output Inverter

Figure 17

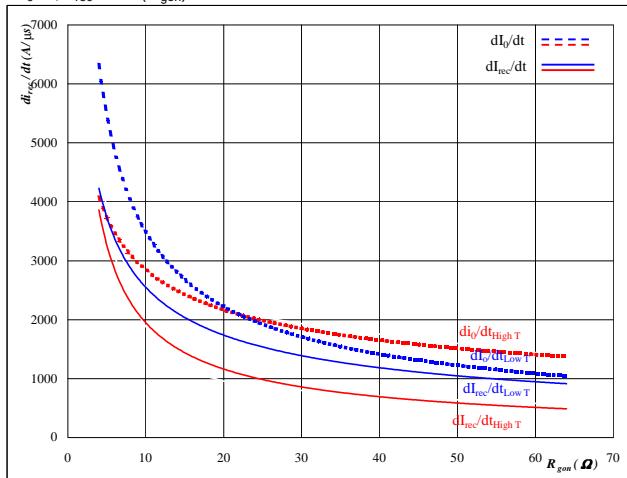
**Typical rate of fall of forward
and reverse recovery current as a
function of collector current**
 $dI_0/dt, dI_{rec}/dt = f(I_C)$


At

$T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 300 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 16 \Omega$

Output inverter FWD
Figure 18

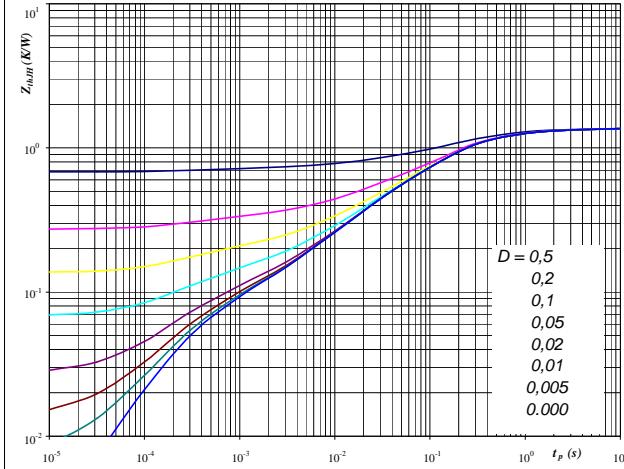
**Typical rate of fall of forward
and reverse recovery current as a
function of IGBT turn on gate resistor**
 $dI_0/dt, dI_{rec}/dt = f(R_{gon})$


At

$T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_R = 300 \text{ V}$
 $I_F = 50 \text{ A}$
 $V_{GE} = \pm 15 \text{ V}$

Figure 19

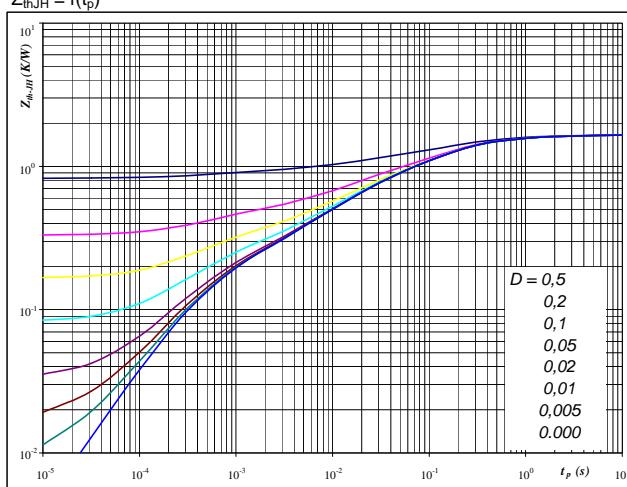
**IGBT transient thermal impedance
as a function of pulse width**

 $Z_{thJH} = f(t_p)$

At

$D = t_p / T$ Phase change material
 $R_{thJH} = 1,25 \text{ K/W}$ $R_{thJH} = 1,06 \text{ K/W}$

Output inverter IGBT
Figure 20

**FWD transient thermal impedance
as a function of pulse width**

 $Z_{thJH} = f(t_p)$

At

$D = t_p / T$ Phase change material
 $R_{thJH} = 1,65 \text{ K/W}$ $R_{thJH} = 1,40 \text{ K/W}$

IGBT thermal model values

Thermal grease		Phase change material	
R (C/W)	Tau (s)	R (C/W)	Tau (s)
0,07	3,7E+00	3,15	3,7E+00
0,28	5,5E-01	0,47	5,5E-01
0,66	1,4E-01	0,12	1,4E-01
0,23	1,9E-02	0,02	1,9E-02
0,05	2,9E-03	0,00	2,9E-03
0,06	3,0E-04	0,00	3,0E-04

FWD thermal model values

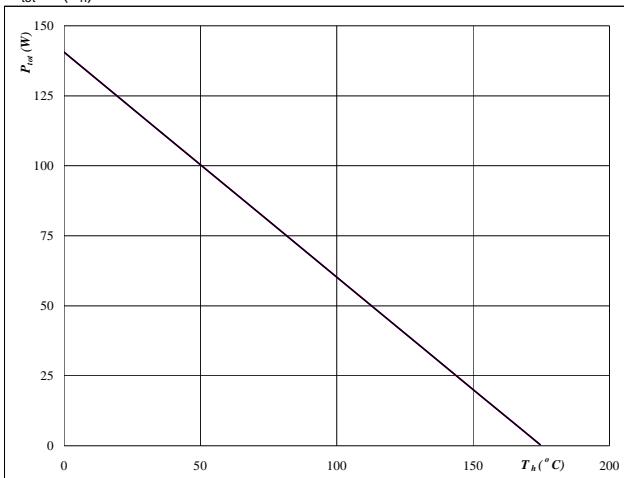
Thermal grease		Phase change material	
R (C/W)	Tau (s)	R (C/W)	Tau (s)
0,08	3,2E+00	2,79	3,2E+00
0,28	4,6E-01	0,39	4,6E-01
0,62	1,1E-01	0,10	1,1E-01
0,39	1,8E-02	0,02	1,8E-02
0,14	3,2E-03	0,00	3,2E-03
0,14	4,1E-04	0,00	4,1E-04

Output Inverter

Figure 21

Power dissipation as a function of heatsink temperature

$$P_{\text{tot}} = f(T_h)$$

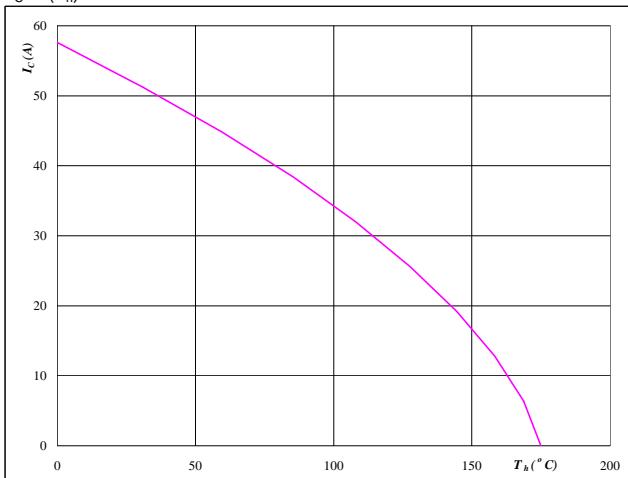

At

$$T_j = 175 \quad ^{\circ}\text{C}$$

Output inverter IGBT
Figure 22

Collector current as a function of heatsink temperature

$$I_C = f(T_h)$$


At

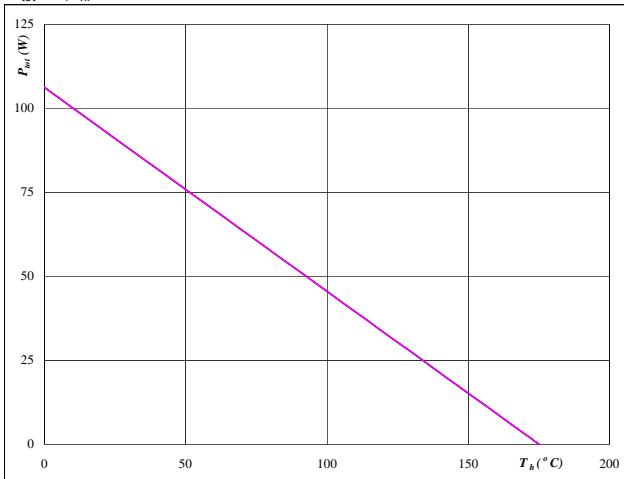
$$T_j = 175 \quad ^{\circ}\text{C}$$

$$V_{GE} = 15 \quad \text{V}$$

Figure 23
Output inverter FWD

Power dissipation as a function of heatsink temperature

$$P_{\text{tot}} = f(T_h)$$

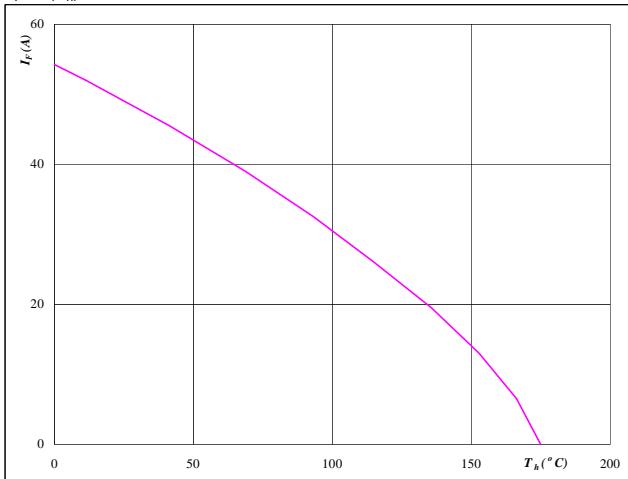

At

$$T_j = 175 \quad ^{\circ}\text{C}$$

Figure 24
Output inverter FWD

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$


At

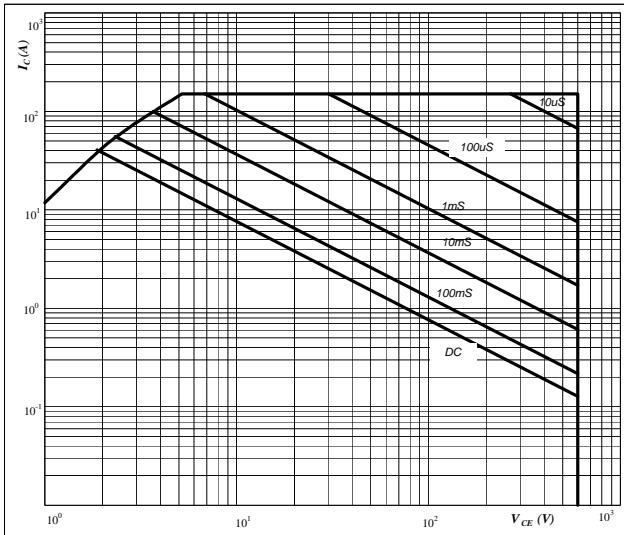
$$T_j = 175 \quad ^{\circ}\text{C}$$

Output Inverter

Figure 25

Safe operating area as a function of collector-emitter voltage

$$I_C = f(V_{CE})$$


At

D = single pulse

T_h = 80 °C

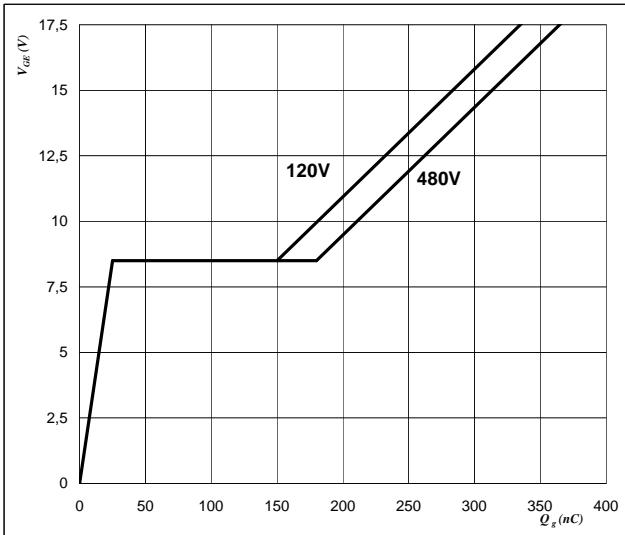
V_{GE} = ±15 V

T_j = T_{jmax} °C

Output inverter IGBT
Figure 26

Gate voltage vs Gate charge

$$V_{GE} = f(Q_{GE})$$

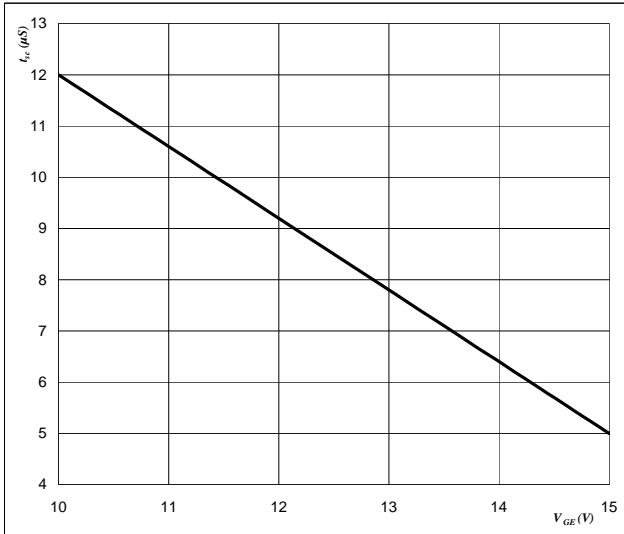

At

I_C = 50 A

Figure 27
Output inverter IGBT

Short circuit withstand time as a function of gate-emitter voltage

$$t_{sc} = f(V_{GE})$$


At

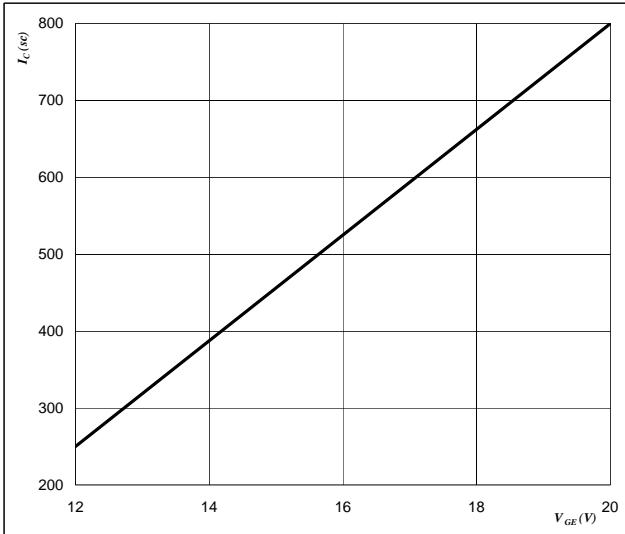
V_{CE} = 600 V

T_j ≤ 175 °C

Figure 28
Output inverter IGBT

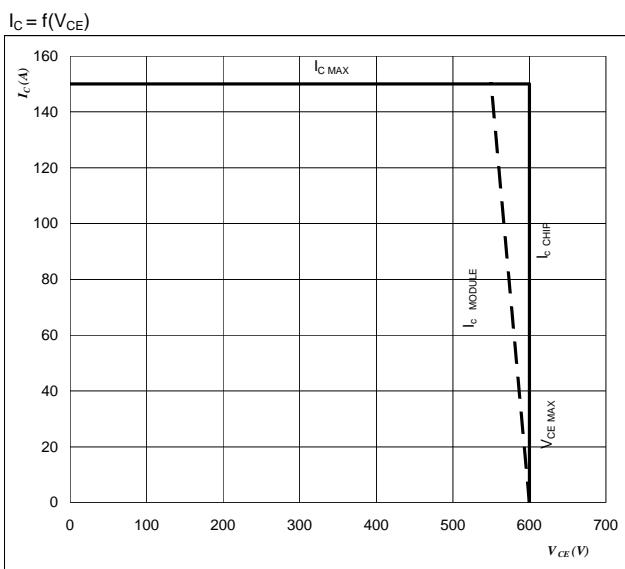
Typical short circuit collector current as a function of gate-emitter voltage

$$V_{GE} = f(Q_{GE})$$


At

V_{CE} ≤ 600 V

T_j = 175 °C

Figure 29
IGBT
Reverse bias safe operating area

At

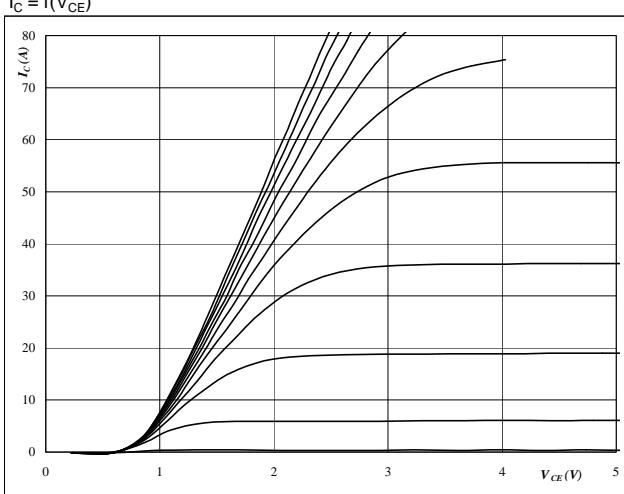
$$T_j = T_{j\max} - 25 \quad ^\circ\text{C}$$

$$U_{ccminus} = U_{ccplus}$$

Switching mode : 3 level switching

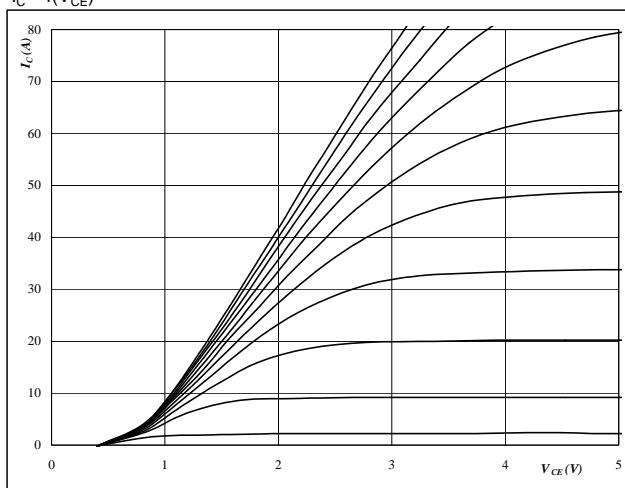
Brake

Figure 1
Typical output characteristics
 $I_C = f(V_{CE})$



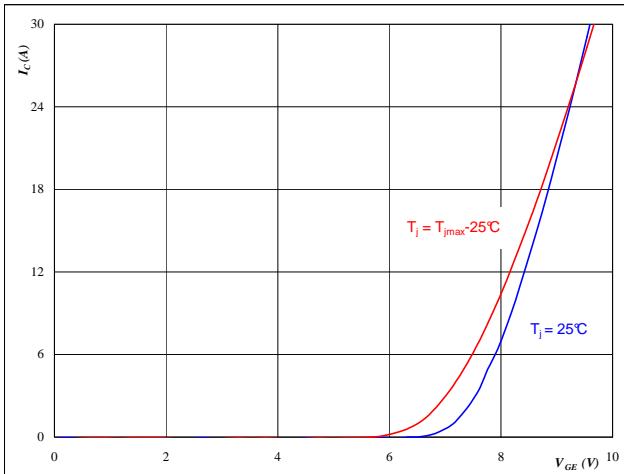
At
 $t_p = 250 \mu s$
 $T_j = 25^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 2
Typical output characteristics
 $I_C = f(V_{CE})$



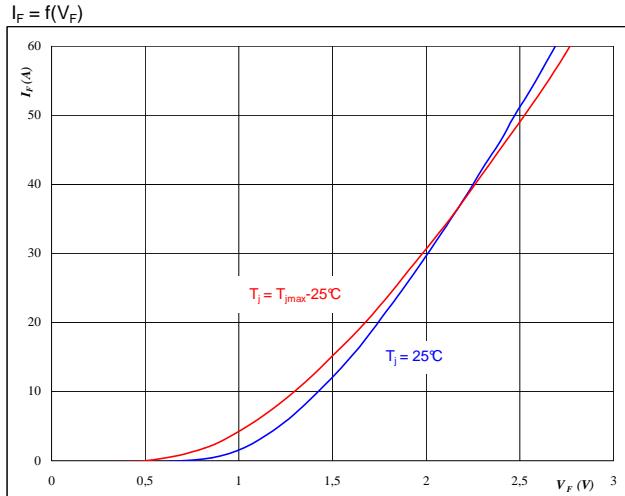
At
 $t_p = 250 \mu s$
 $T_j = 125^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 3
Typical transfer characteristics
 $I_C = f(V_{GE})$



At
 $t_p = 250 \mu s$
 $V_{CE} = 10 V$

Figure 4
Typical diode forward current as a function of forward voltage
 $I_F = f(V_F)$



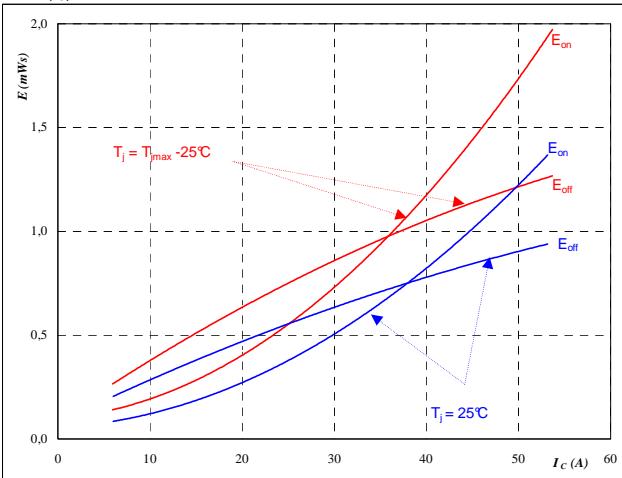
At
 $t_p = 250 \mu s$

Brake

Figure 5

**Typical switching energy losses
as a function of collector current**

$$E = f(I_C)$$



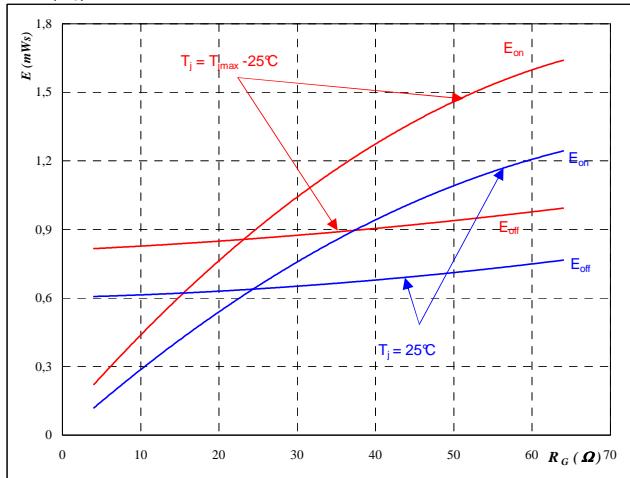
With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 16 \quad \Omega \\ R_{goff} &= 16 \quad \Omega \end{aligned}$$

Brake IGBT
Figure 6

**Typical switching energy losses
as a function of gate resistor**

$$E = f(R_G)$$



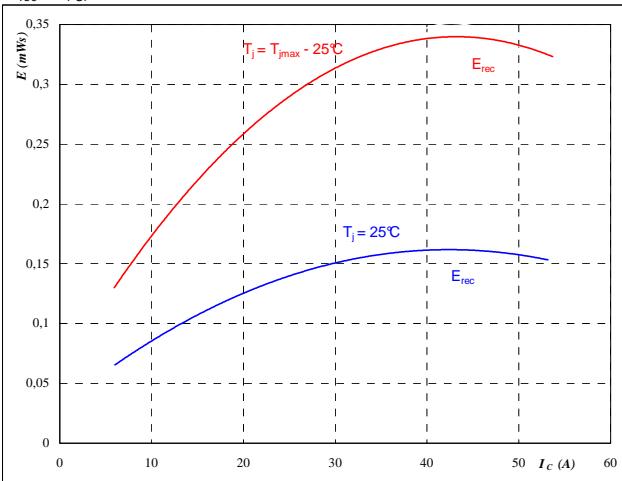
With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ I_C &= 29 \quad \text{A} \end{aligned}$$

Figure 7

**Typical reverse recovery energy loss
as a function of collector current**

$$E_{rec} = f(I_C)$$



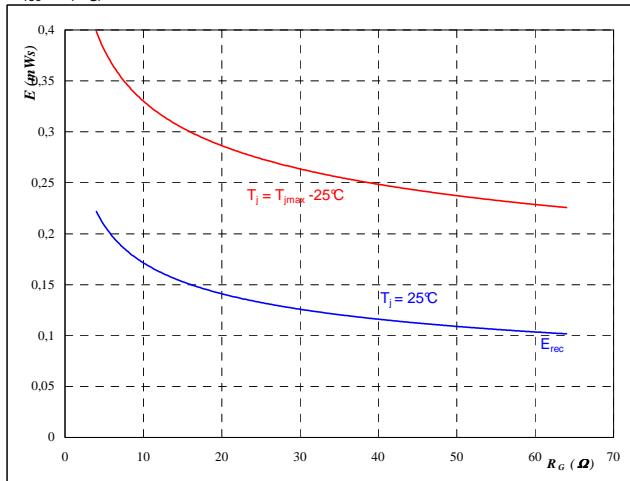
With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 16 \quad \Omega \end{aligned}$$

Figure 8

**Typical reverse recovery energy loss
as a function of gate resistor**

$$E_{rec} = f(R_G)$$



With an inductive load at

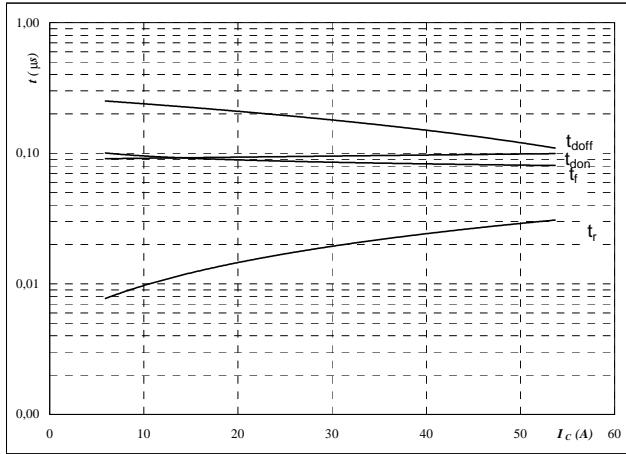
$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{CE} &= 300 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ I_C &= 29 \quad \text{A} \end{aligned}$$

Brake

Figure 9

Brake IGBT

Typical switching times as a function of collector current
 $t = f(I_C)$



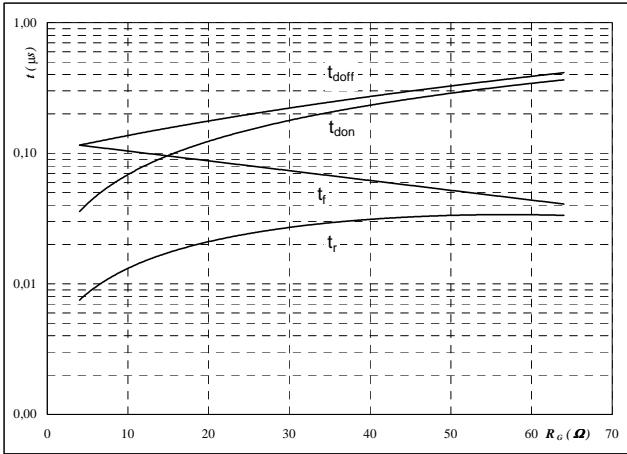
With an inductive load at

T _j =	125	°C
V _{CE} =	300	V
V _{GE} =	±15	V
R _{gon} =	16	Ω
R _{goff} =	16	Ω

Figure 10

Brake IGBT

Typical switching times as a function of gate resistor
 $t = f(R_G)$



With an inductive load at

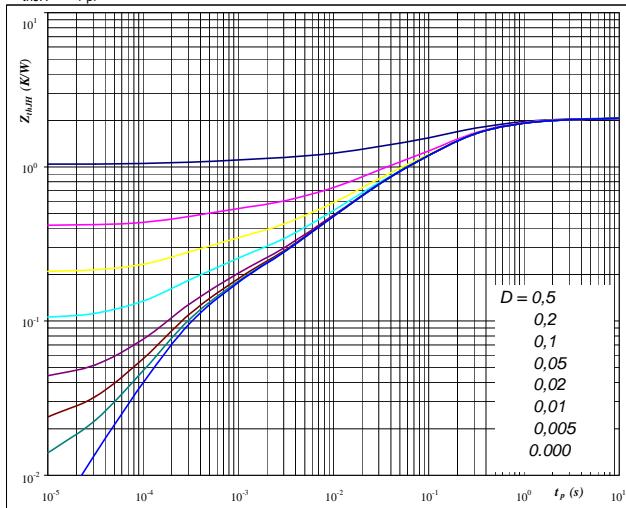
T _j =	125	°C
V _{CE} =	300	V
V _{GE} =	±15	V
I _C =	29	A

Figure 11

Brake IGBT

IGBT transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At **D =** **tp / T**

Thermal grease

$R_{thJH} = 2,07 \text{ K/W}$

Phase change material

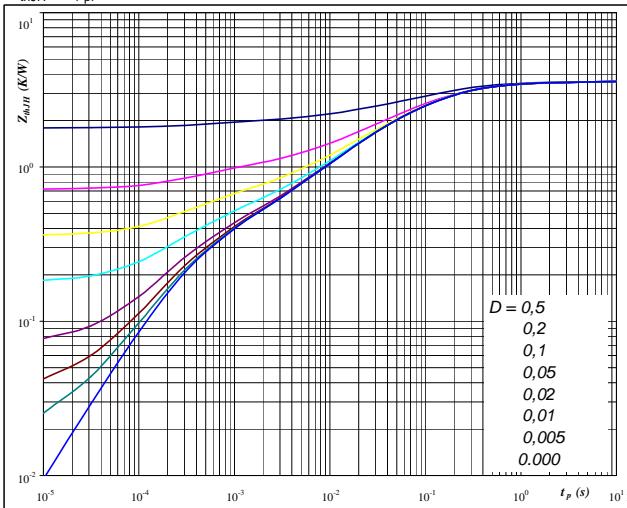
$R_{thJH} = 1,78 \text{ K/W}$

Figure 12

Brake FWD

FWD transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At **D =** **tp / T**

Thermal grease

$R_{thJH} = 3,58 \text{ K/W}$

Phase change material

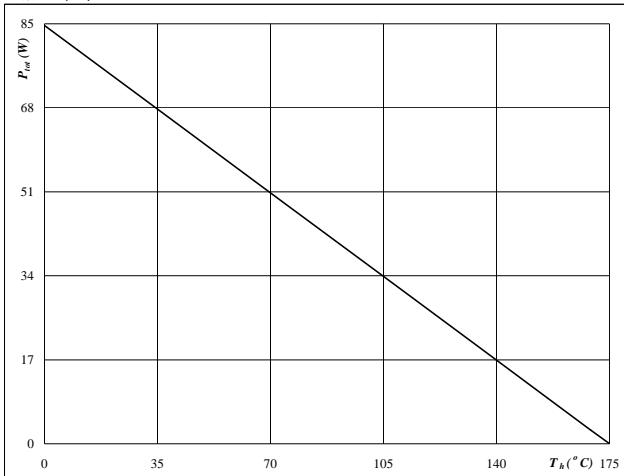
$R_{thJH} = 3,11 \text{ K/W}$

Brake

Figure 13

Power dissipation as a function of heatsink temperature

$$P_{\text{tot}} = f(T_h)$$

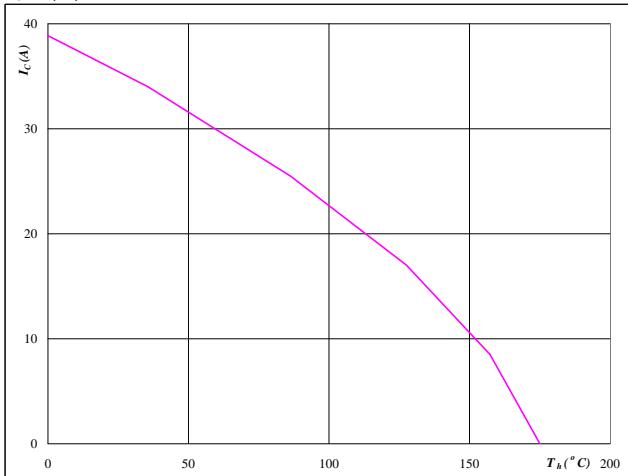

At

$$T_j = 175 \text{ } ^\circ\text{C}$$

Brake IGBT
Figure 14

Collector current as a function of heatsink temperature

$$I_C = f(T_h)$$


At

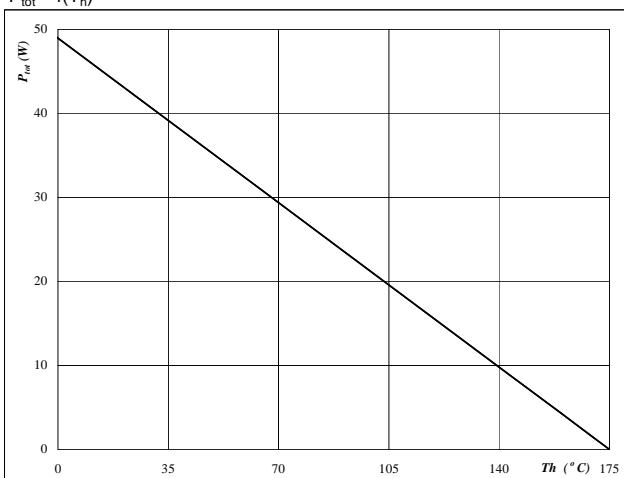
$$T_j = 175 \text{ } ^\circ\text{C}$$

$$V_{GE} = 15 \text{ V}$$

Figure 15

Power dissipation as a function of heatsink temperature

$$P_{\text{tot}} = f(T_h)$$

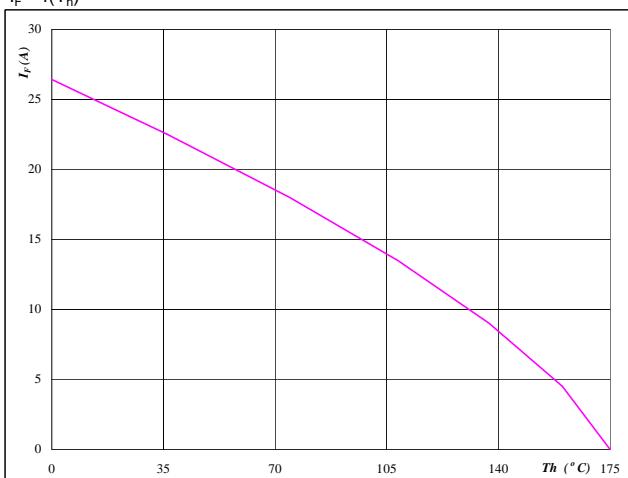

At

$$T_j = 175 \text{ } ^\circ\text{C}$$

Brake FWD
Figure 16

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$


At

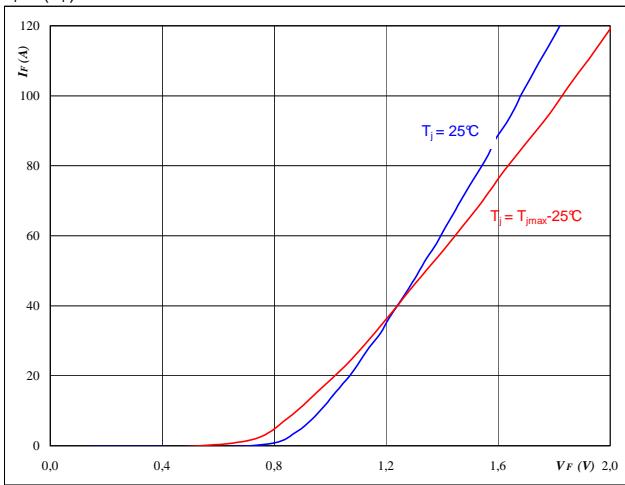
$$T_j = 175 \text{ } ^\circ\text{C}$$

Input Rectifier Bridge

Figure 1

Typical diode forward current as a function of forward voltage

$$I_F = f(V_F)$$

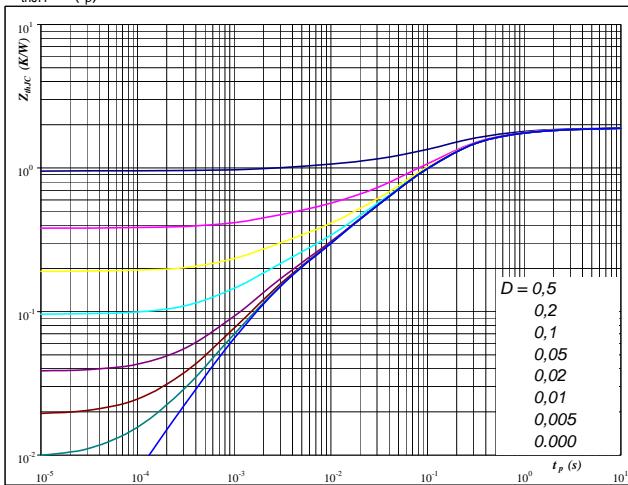

At

$$t_p = 250 \mu\text{s}$$

Rectifier diode
Figure 2

Diode transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$


At

$$D = t_p / T$$

Thermal grease

$$R_{thJH} = 1.89 \text{ K/W}$$

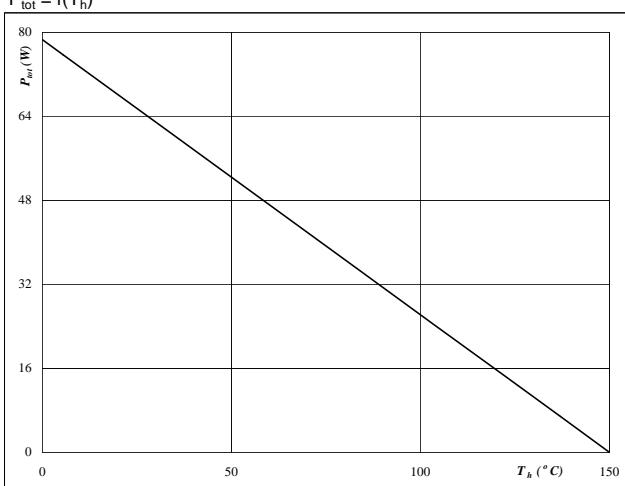
Phase change material

$$R_{thJH} = 1.62 \text{ K/W}$$

Rectifier diode
Figure 3

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

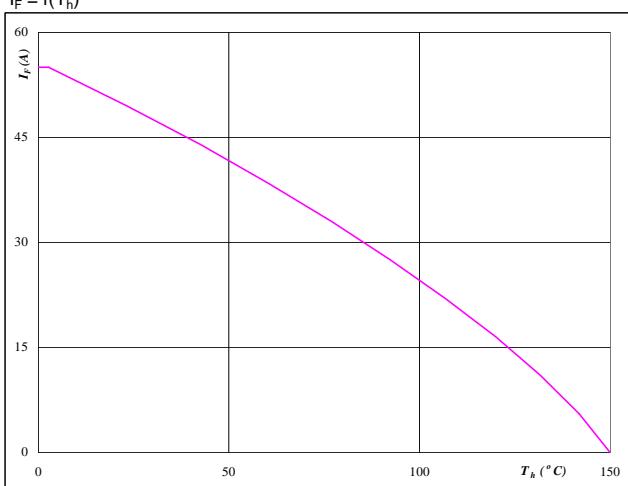

At

$$T_j = 150^\circ\text{C}$$

Rectifier diode
Figure 4

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$


At

$$T_j = 150^\circ\text{C}$$

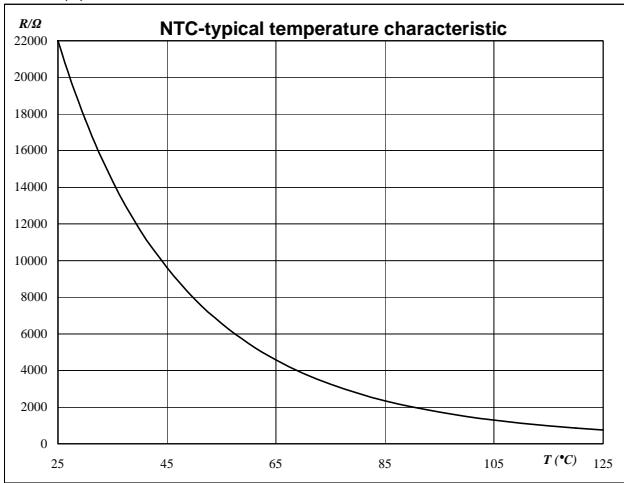
Rectifier diode

Thermistor

Figure 1

**Typical NTC characteristic
as a function of temperature**

$$R_T = f(T)$$


Thermistor
Figure 2

Typical NTC resistance values

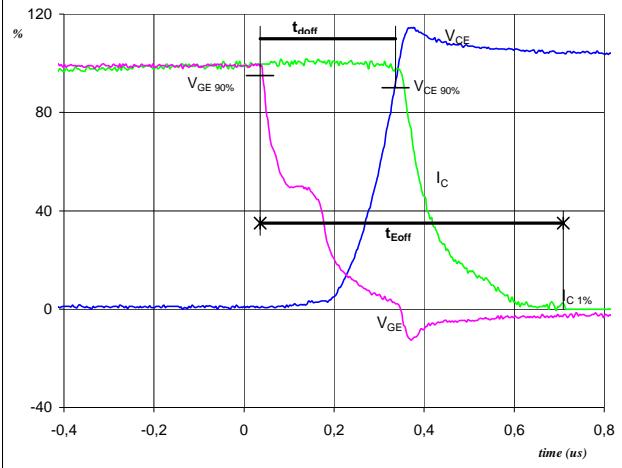
$$R(T) = R_{25} \cdot e^{\left(B_{25/100} \left(\frac{1}{T} - \frac{1}{T_{25}} \right) \right)} \quad [\Omega]$$

T [°C]	R _{nom} [Ω]	R _{min} [Ω]	R _{max} [Ω]	△R/R [%]
-55	2089434,5	1506495,4	2672373,6	27,9
0	71804,2	59724,4	83884	16,8
10	43780,4	37094,4	50466,5	15,3
20	27484,6	23684,6	31284,7	13,8
25	22000	19109,3	24890,7	13,1
30	17723,3	15512,2	19934,4	12,5
60	5467,9	4980,6	5955,1	8,9
70	3848,6	3546	4151,1	7,9
80	2757,7	2568,2	2947,1	6,9
90	2008,9	1889,7	2128,2	5,9
100	1486,1	1411,8	1560,4	5
150	400,2	364,8	435,7	8,8

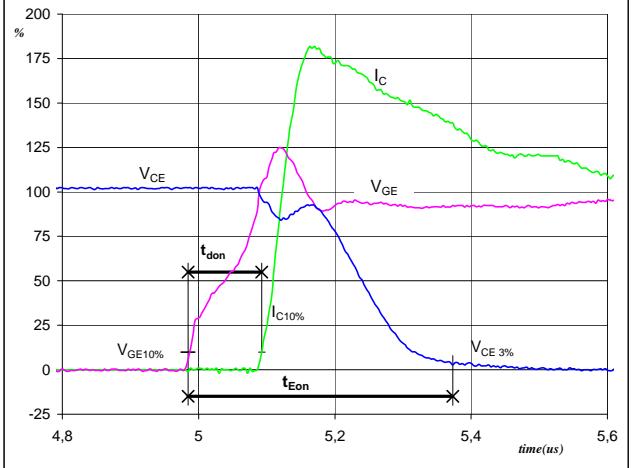
Switching Definitions Output Inverter

General conditions

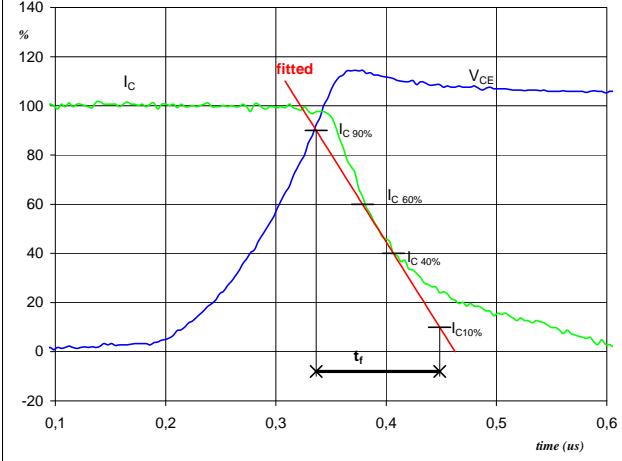
T_j	=	125 °C
R_{gon}	=	4 Ω
R_{goff}	=	4 Ω

Figure 1
Output inverter IGBT
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
 $(t_{Eoff} = \text{integrating time for } E_{off})$


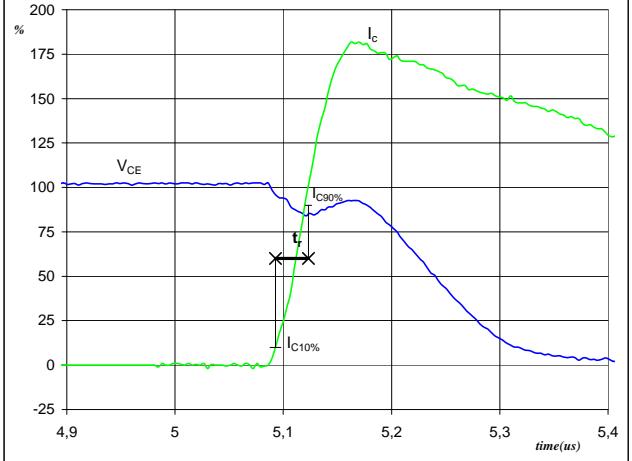
$V_{GE}(0\%) = -15$ V
 $V_{GE}(100\%) = 15$ V
 $V_C(100\%) = 600$ V
 $I_C(100\%) = 100$ A
 $t_{doff} = 0,29$ μs
 $t_{Eoff} = 0,67$ μs

Figure 2
Output inverter IGBT
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
 $(t_{Eon} = \text{integrating time for } E_{on})$


$V_{GE}(0\%) = -15$ V
 $V_{GE}(100\%) = 15$ V
 $V_C(100\%) = 600$ V
 $I_C(100\%) = 100$ A
 $t_{don} = 0,11$ μs
 $t_{Eon} = 0,39$ μs

Figure 3
Output inverter IGBT
Turn-off Switching Waveforms & definition of t_f


$V_C(100\%) = 600$ V
 $I_C(100\%) = 100$ A
 $t_f = 0,11$ μs

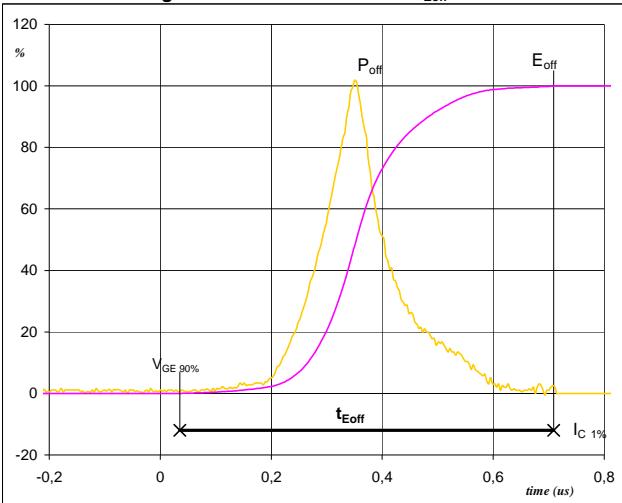
Figure 4
Output inverter IGBT
Turn-on Switching Waveforms & definition of t_r


$V_C(100\%) = 600$ V
 $I_C(100\%) = 100$ A
 $t_r = 0,03$ μs

Switching Definitions Output Inverter

Figure 5

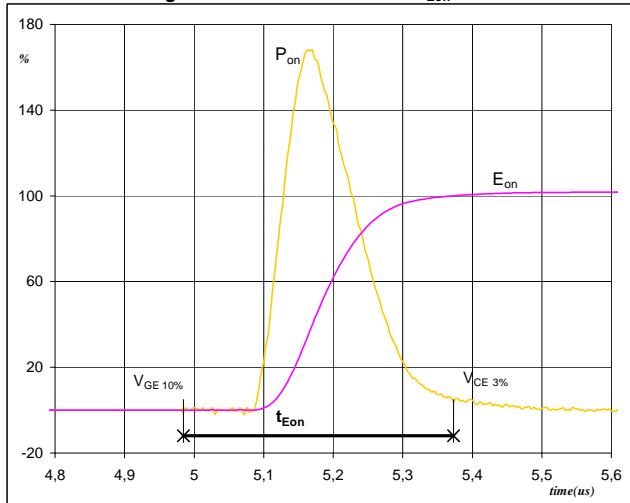
Output inverter IGBT

Turn-off Switching Waveforms & definition of t_{Eoff}


$P_{off} (100\%) = 59,91 \text{ kW}$
 $E_{off} (100\%) = 8,87 \text{ mJ}$
 $t_{Eoff} = 0,67 \mu\text{s}$

Figure 6

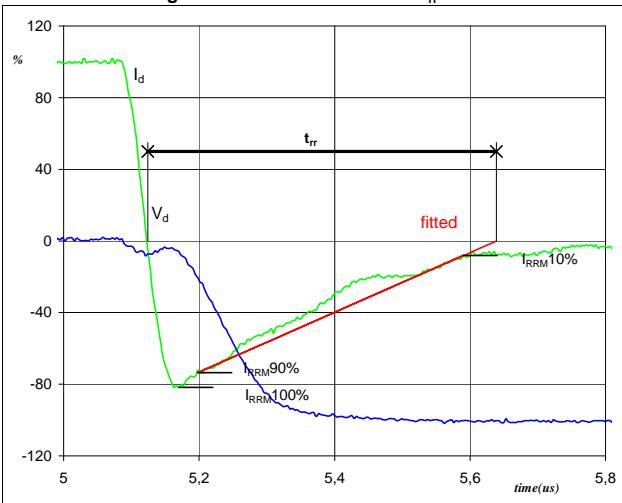
Output inverter IGBT

Turn-on Switching Waveforms & definition of t_{Eon}


$P_{on} (100\%) = 59,91 \text{ kW}$
 $E_{on} (100\%) = 12,48 \text{ mJ}$
 $t_{Eon} = 0,39 \mu\text{s}$

Figure 7

Output inverter IGBT

Turn-off Switching Waveforms & definition of t_{rr}


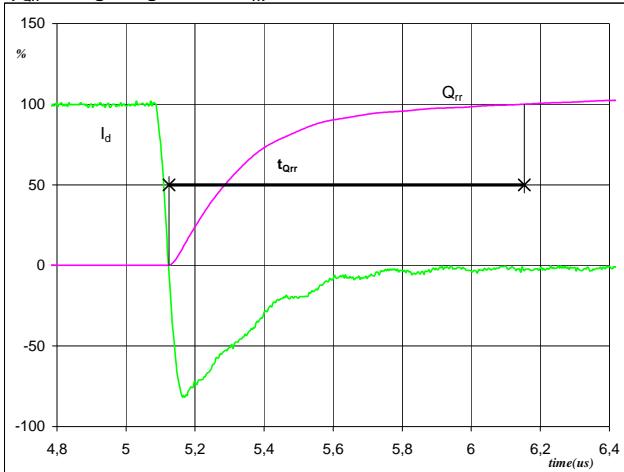
$V_d (100\%) = 600 \text{ V}$
 $I_d (100\%) = 100 \text{ A}$
 $I_{RRM} (100\%) = -83 \text{ A}$
 $t_{rr} = 0,51 \mu\text{s}$

Switching Definitions Output Inverter

Figure 8

Output inverter FWD

Turn-on Switching Waveforms & definition of t_{Qrr}
 $(t_{Qrr} = \text{integrating time for } Q_{rr})$

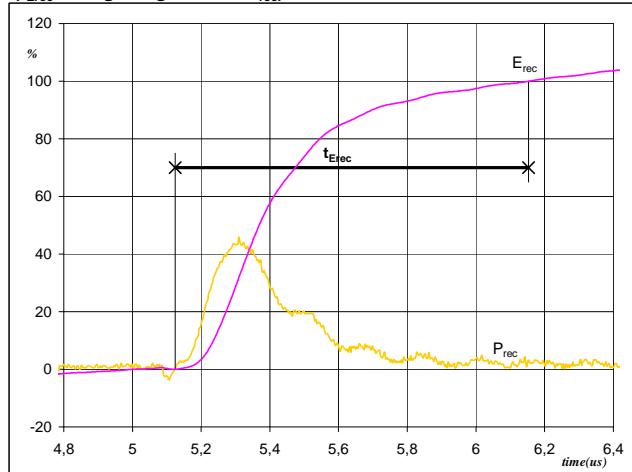


$$\begin{aligned} I_d(100\%) &= 100 \quad \text{A} \\ Q_{rr}(100\%) &= 20,73 \quad \mu\text{C} \\ t_{Qrr} &= 1,03 \quad \mu\text{s} \end{aligned}$$

Figure 9

Output inverter FWD

Turn-on Switching Waveforms & definition of t_{Erec}
 $(t_{Erec} = \text{integrating time for } E_{rec})$



$$\begin{aligned} P_{rec}(100\%) &= 59,91 \quad \text{kW} \\ E_{rec}(100\%) &= 7,85 \quad \text{mJ} \\ t_{Erec} &= 1,03 \quad \mu\text{s} \end{aligned}$$

Ordering Code and Marking - Outline - Pinout

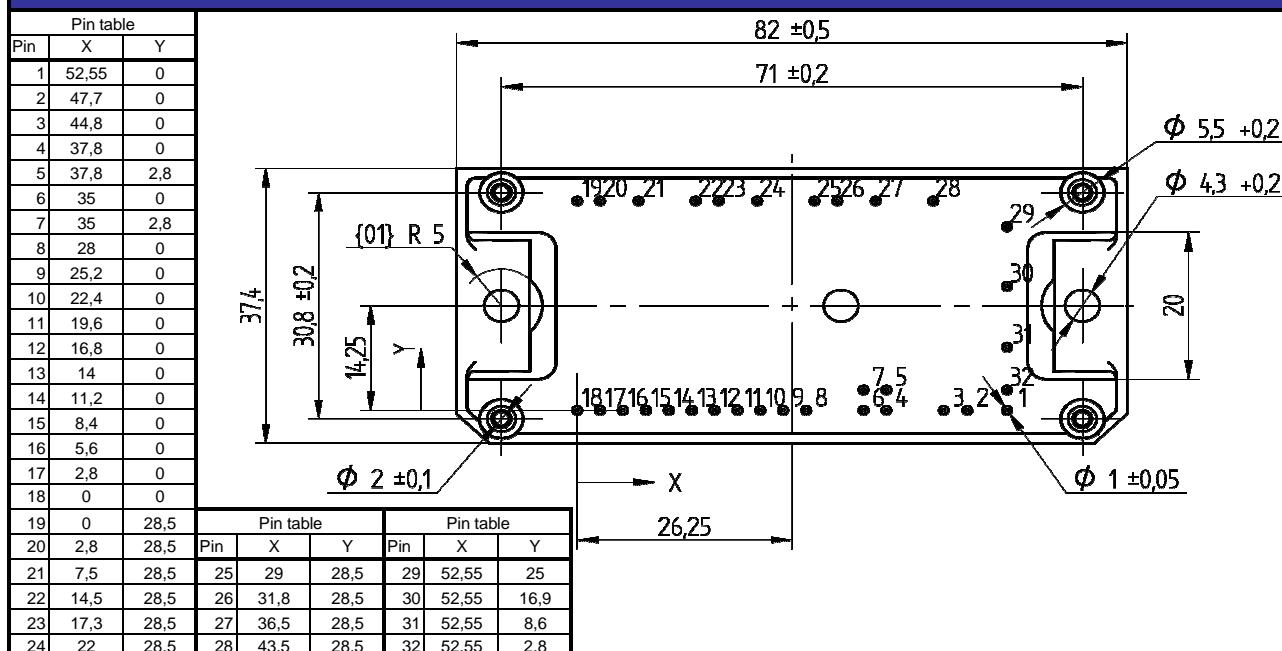
Ordering Code & Marking

Version	Ordering Code	in DataMatrix as	in packaging barcode as
17mm housing with solder pins and break	V23990-P586-A20-PM	P586-A20-PM	P586-A20-PM
17mm housing with pressfit pins and break	V23990-P586-A20Y-PM	P586-A20Y-PM	P586-A20Y-PM
12mm housing with solder pins and break	V23990-P586-A208-PM	P586-A208-PM	P586-A208-PM
17mm housing with solder pins w/o break	V23990-P586-C20-PM	P586-C20-PM	P586-C20-PM
17mm housing with pressfit pins w/o break	V23990-P586-C20Y-PM	P586-C20Y-PM	P586-C20Y-PM

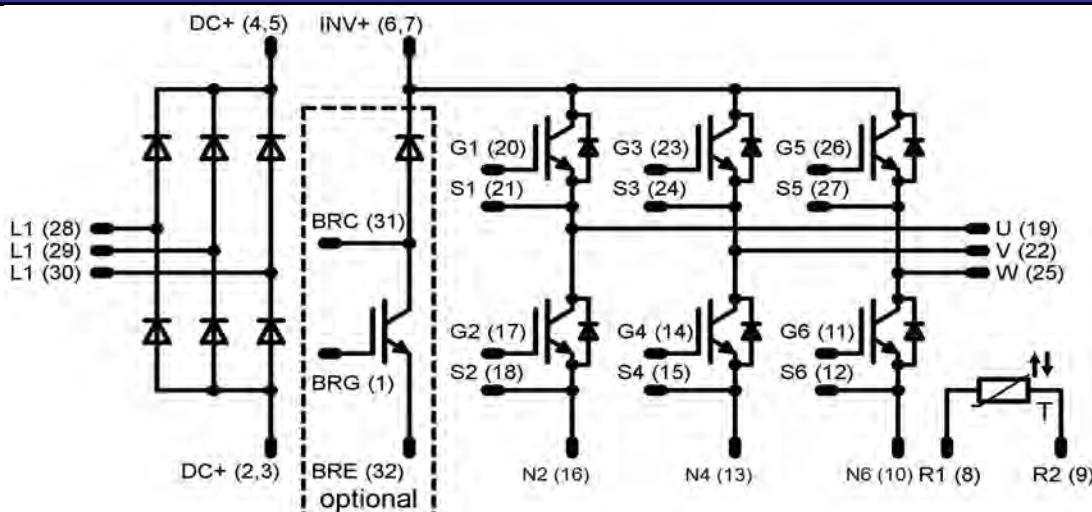
Features

	A version	C version
Rectifier	3-leg	3-leg
Break IGBT	✓	w/o pin 1,31,32
Break FWD	✓	
Inverter IGBT	✓	✓
Inverter FWD	✓	✓

Outline



Pinout



DISCLAIMER

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1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in labelling can be reasonably expected to result in significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.